

Notice of References Cited	Application/Control No. 10/702,361		Applicant(s)/Patent Under Reexamination MERLAU ET AL.	
	Examiner David L. Vanik		Art Unit 1615	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,136,884	10-2000	Chen et al.	523/105
	B	US-			
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO 99/63955	11-1999	France	Samain et al.	A61K 7/06
*	O	JP 103513/92	04-1992	Japan	KAO Corperation	A61K 7/06
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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